


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510392	<b>Applicant(s)/Patent Under Reexamination</b>  NAPPER ET AL.
	<b>Examiner</b>  JON CHANG	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search	03/27/09	JC
382/119-123, 186-189, 313-315 (text search only - see search history printout)	03/26/09 and 03/27/09	JC
Classes 382, 358 and 345 (text search only - see search history printout)	03/28/09	JC
IEEE Search	03/28/09	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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